

# MOSFET - POWERTRENCH® Single N-Channel, DUAL COOL®

80 V, 3.1 mΩ, 110 A

# **FDMS86300DC**

### **General Description**

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH® process that incorporates Shielded Gate technology. Advancements in both silicon and DUAL COOL® package technologies have been combined to offer the lowest  $r_{DS(on)}$  while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

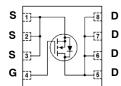
### **Features**

- DUAL COOL® Top Side Cooling PQFN package
- Max  $r_{DS(on)} = 3.1 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 24 \text{ A}$
- Max  $r_{DS(on)} = 4.0 \text{ m}\Omega$  at  $V_{GS} = 8 \text{ V}$ ,  $I_D = 21 \text{ A}$
- High performance technology for extremely low r<sub>DS(on)</sub>
- 100% UIL Tested
- RoHS Compliant

### **Typical Applications**

- Synchronous Rectifier for DC/DC Converters
- Telecom Secondary Side Rectification
- High End Server/Workstation Vcore Low Side

### **ELECTRICAL CONNECTION**

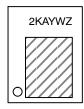


**N-Channel MOSFET** 



DFN8 (DUAL COOL<sup>®</sup>) CASE 506EG

#### **MARKING DIAGRAM**



2K = Specific Device Code A = Assembly Location

Y = Year W = Work Week

Z = Assembly Lot Code

### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

### PACKAGE MARKING AND ORDERING INFORMATION

Device	Device Marking	Package	Reel Size	Tape Width	Shipping <sup>†</sup>
FDMS86300DC	2K	UDFN8	13"	12 mm	3000 Units/ Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **MOSFET MAXIMUM RATINGS** ( $T_A = 25$ °C unless otherwise noted)

Symbol	Parameter			Ratings	Units	
$V_{DS}$	Drain to Source	/oltage			80	V
$V_{GS}$	Gate to Source V	/oltage			±20	V
I <sub>D</sub>	Drain Current	-Continuous	T <sub>C</sub> = 25°C		110	Α
		-Continuous	T <sub>A</sub> = 25°C	(Note 1a)	24	
		-Pulsed		(Note 2)	260	
E <sub>AS</sub>	Single Pulse Ava	lanche Energy		(Note 3)	240	mJ
$P_{D}$	Power Dissipatio	n	T <sub>C</sub> = 25°C		125	W
	Power Dissipatio	n	T <sub>A</sub> = 25°C	(Note 1a)	3.2	
T <sub>J</sub> , T <sub>STG</sub>	J, T <sub>STG</sub> Operating and Storage Junction Temperature Range			-55 to +150	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
OFF CHAF	ACTERISTICS					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu\text{A},  V_{GS} = 0 \text{V}$	80			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C		45		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 64 V, V <sub>GS</sub> = 0 V			1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±100	nA
ON CHAR	ACTERISTICS					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.5	3.3	4.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Tempera- ture Coefficient	I <sub>D</sub> = 250 μA, referenced to 25°C		-11		mV/°C
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 24 A		2.6	3.1	mΩ
		V <sub>GS</sub> = 8 V, I <sub>D</sub> = 21 A		3.1	4.0	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 24 A, T <sub>J</sub> = 125°C		4.1	5.0	
9FS	Forward Transconductance	V <sub>DD</sub> = 10 V, I <sub>D</sub> = 24 A		79		S
DYNAMIC	CHARACTERISTICS					
C <sub>ISS</sub>	Input Capacitance	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, f = 1 MHz		5265	7005	pF
C <sub>OSS</sub>	Output Capacitance	1		929	1235	pF
C <sub>RSS</sub>	Reverse Transfer Capacitance	1		21	50	pF
$R_{G}$	Gate Resistance		0.1	1.2	2.6	Ω

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
SWITCHIN	IG CHARACTERISTICS			•		•
td <sub>(ON)</sub>	Turn – On Delay Time	V <sub>DD</sub> = 40 V, I <sub>D</sub> = 24 A,		29	47	ns
t <sub>r</sub>	Rise Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$		25	44	ns
t <sub>D(OFF)</sub>	Turn – Off Delay Time	7		35	57	ns
t <sub>f</sub>	Fall Time	7		9	18	ns
Q <sub>g(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V		72	101	nC
	Total Gate Charge	V <sub>GS</sub> = 0 V to 8 V		59	84	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	V <sub>DD</sub> = 40 V,		26		nC
$Q_{gd}$	Gate to Drain "Miller" Charge	I <sub>D</sub> = 24 A		14		nC
DRAIN-SC	DURCE DIODE CHARACTERISTICS					
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.7 A (Note 2)		0.72	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 24 A (Note 2)		0.80	1.3	
t <sub>rr</sub>	Reverse Recovery Time			56	88	ns
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 24 A, di/dt = 100 A/μs		42	67	nC

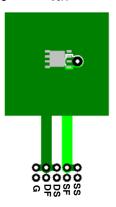
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

### THERMAL CHARACTERISTICS

Symbol	Parameter		Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	2.3	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.0	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	27	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	19	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	61	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	11	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	13	

#### NOTES:

R<sub>θJA</sub> is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>θJC</sub> is guaranteed by design while R<sub>θCA</sub> is determined by the user's board design.



a) 38°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b) 81°C/W when mounted on a minimum pad of 2 oz copper.

- c) Still air, 20.9×10.4×12.7 mm Aluminum Heat Sink, 1 in  $^2$  pad of 2 oz copper
- d) Still air, 20.9×10.4×12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e) Still air, 45.2×41.4×11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- f) Still air, 45.2×41.4×11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g) .200FPM Airflow, No Heat Sink, 1 in2 pad of 2 oz copper
- h) .200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i) .200FPM Airflow, 20.9×10.4×12.7 mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- j) .200FPM Airflow, 20.9×10.4×12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k) .200FPM Airflow, 45.2×41.4×11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- l) .200FPM Airflow, 45.2×41.4×11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- 2. Pulse Test: Pulse Width  $< 300 \mu s$ , Duty cycle < 2.0%.
- 3. Starting  $T_J = 25$  °C; N-ch: L = 0.3 mH,  $I_{AS} = 40$  A,  $V_{DD} = 72$  V,  $V_{GS} = 10$  V.

# TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C UNLESS OTHERWISE NOTED)

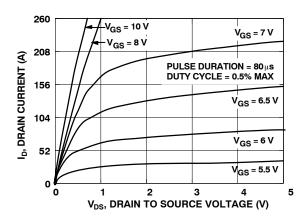


Figure 1. On Region Characteristics

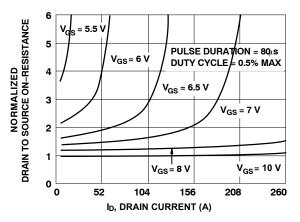


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

# TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C UNLESS OTHERWISE NOTED)

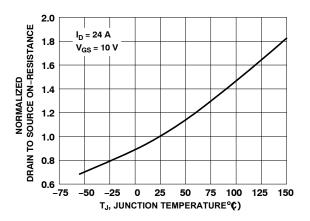
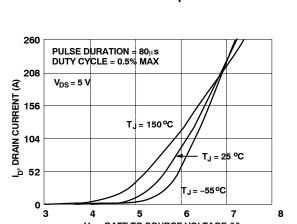


Figure 3. Normalized On Resistance vs. Junction Temperature



V<sub>GS</sub>, GATE TO SOURCE VOLTAGE (V)
Figure 5. Transfer Characteristics

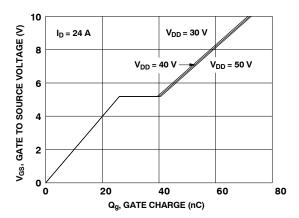


Figure 7. Gate Charge Characteristics

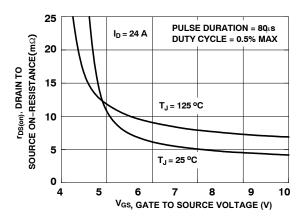


Figure 4. On-Resistance vs. Gate to Source Voltage

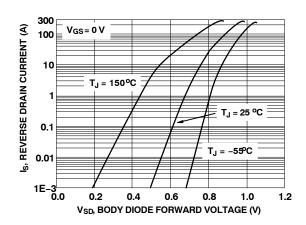


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

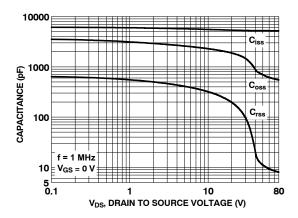


Figure 8. Capacitance vs. Drain to Source Voltage

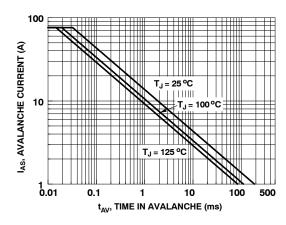


Figure 9. Unclamped Inductive Switching Capability

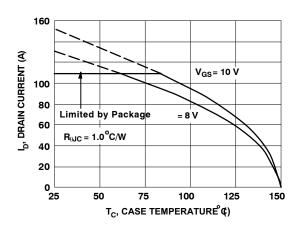


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

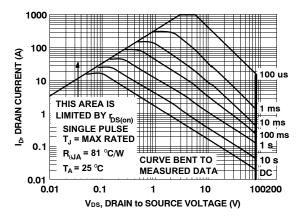


Figure 11. Forward Bias Safe Operating Area

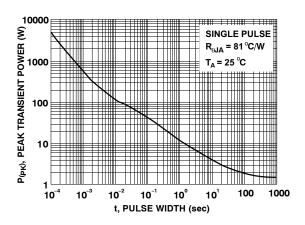


Figure 12. Single Pulse Maximum Power Dissipation

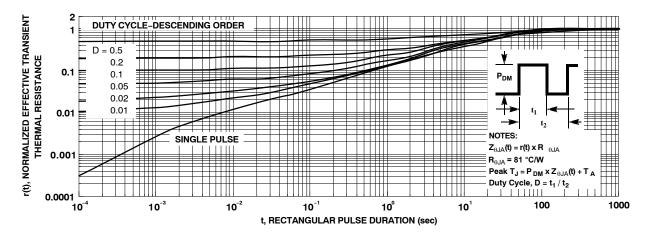
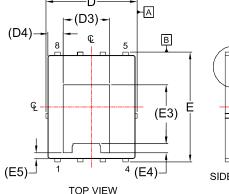


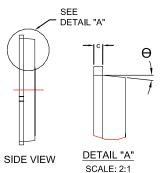
Figure 13. Junction-to-Case Transient Thermal Response Curve

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### DFN8 5x6.15, 1.27P, DUAL COOL CASE 506EG ISSUE D

**DATE 25 AUG 2020** 

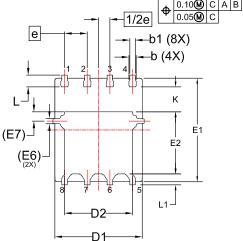




### NOTES:

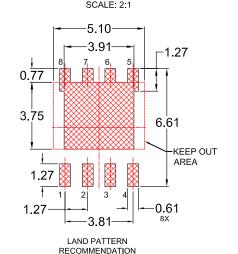
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

	// 0.10 C	A2	<b>·</b> −⊖
FRONT VIEW SEE DETAIL "B"	8X   A		PLANE
0.400		DETAIL "B"	C





**BOTTOM VIEW** 



\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

DIM	IV	IILL <b>I</b> MET	ERS
Diw	MIN.	NOM.	MAX.
Α	0.85	0.90	0.95
A1	-	-	0.05
A2	ı	-	0.05
b	0.31	0.41	0.51
b1	0.21	0.31	0.41
С	0.20	0.25	0.30
D	4.90	5.00	5,10
D1	4.80	4.90	5.00
D2	3.67	3.82	3.97
D3		2.60 RE	F
D4		0.86 RE	F
Е	6.05	6.15	6.25
E1	5.70	5.80	5.90
E2	3.38	3.48	3.58
E3	;	3.30 REF	-
E4		0.50 REF	•
E5	Ü	0.34 REF	:
E6	(	0.30 REF	
E7		0.52 REF	:
Ф	1	1.27 BSC	:
1/2e	0.635 BSC		
K	1.30	1.40	1.50
L	0.56	0.66	0.76
L1	0.52	0.62	0.72
Д	٥°		12°



XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

ZZ = Assembly Lot Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON84257G	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED"	
DESCRIPTION:	DESCRIPTION: DFN8 5x6.15, 1.27P, DUAL COOL		PAGE 1 OF 1

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